## Search Notes



P	۱p	pΙ	ica	tic	n/	Cc	nt	rol	No

10559830

Applicant(s)/Patent Under Reexamination

MINAKATA ET AL.

Examiner

Strieb, Michael A

Art Unit

2809

## **SEARCHED**

Class	Subclass	Date	Examiner
359	687	9/17/2008	MAS

## **SEARCH NOTES**

Search Notes	Date	Examiner
Inventor search	08/23/2007	MAS
EAST text search	08/23/2007	MAS
Met with Primary Examiner Benny Tieu	8/23/2007	MAS
Consulted with Primary Examiner Scott Sugarman	8/23/2007	MAS
EAST text search	10/22, 10/23,	MAS
	10/29/2007	
updated EAST text search	9/17/2008	MAS

	INTERFERENCE SEAR	СН	
Class	Subclass	Date	Examiner

/MICHAEL A STRIEB/ Examiner.Art Unit 2862	

U.S. Patent and Trademark Office Part of Paper No.: 20080917